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Report No.: SZEM180100021803
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Test REPORT

Application No: SZEM1801000218RG
Applicant: Huawei Technologies Co., Ltd.
Manufacturer: Huawei Technologies Co., Ltd..
Factory: Huawei Technologies Co., Ltd.
Product Name: Smart Phone
Model No.(EUT): CLT-L29
Trade Mark: HUAWEI
FCC ID: QISCLT-L29
Standards: 47 CFR Part 2(2018)
47 CFR Part 22 subpart H(2018)
Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v03
TIA-603-E 2016
Date of Receipt: 2018-02-10
Date of Test: 2018-02-12 to 2018-02-15
Date of Issue: 2018-02-22

Test Result:	PASS *
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* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:

Derek Yang
Wireless Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2018-02-22		Original

Authorized for issue by:				
Tested By		 (Mike Hu) /Project Engineer		
				Date
Checked By		 (Jim Huang) /Reviewer		
				Date



3 Test Summary

Test Item	FCC&IC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913,	ERP≤7W BAND 26(824-849)}	Section 1 of Appendix B	PASS
Peak-Average Ratio	N/A	≤13dB	Section 2 of Appendix B	PASS
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	PASS
Bandwidth	§2.1049(h), §22.917,	OBW:No limit EBW: No limit	Section 4 of Appendix B	PASS
Band Edge Compliance	§2.1051, §22.917,	1,≤ -13dBm	Section 5 of Appendix B	PASS
Spurious emissions at antenna terminals	§2.1051, §22.917,	1,≤ -13dBm	Section 6 of Appendix B	PASS
Field strength of spurious radiation	§2.1051, §22.917,	1,≤ -13dBm	Section 7 of Appendix B	PASS
Frequency stability	§2.1055, §22.355,	≤ ±2.5ppm.	Section 8 of Appendix B	PASS

Remark:

This test report (Report No.: **SZEM180100021803**) is base on the original test report (Report No.:

SZEM180100021703)

According to the declaration from the applicant, the differences between CLT-L04 and CLT-L29 are as follows.

	Model	CLT-L04	CLT-L29
Licensed Frequency	LTE BAND	FCC Band: B2/B4/ B5/B7/B12/B17/B26/B38/ B40/B41 MIMO B4/B7	FCC Band: B2/B4/ B5/B7/B12/B17/B26/B38/ B40/B41 MIMO B3/B7
	UMTS BAND	B2/B5/B8	B2/B5/B8
	GSM	B3/B3 /B5/B8	B3/B3 /B5/B8
	IC	the same	the same
	Antenna	the same	the same
	NFC	the same	N the same
Unlicensed Frequency	Bluetooth	the same	the same
	2.4G Wi-Fi	the same	the same



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	IC	the same	the same
	Antenna	The power of B40 is different 4*4 MIMO B4/B7 support RX and TX	The power of B40 is different 4*4MIMO B3/B7 support RX and TX
Hardware	Ram / Rom	the same	the same
	Camera	the same	the same
	PCB	the same	the same
	USB Port	the same	the same
	SIM	the same	the same
	Hardware version	the same	the same
RF	RF circuit	L3609/L3624/L3605/Z3602/C3631/L3623/C3625/L3611 disable weld, C3629 use DNI ; L3546/C3531/L3518/Z3502/L3530/C3532/L3517/L3529/L3504/L3505/Z3501/L3528/L3503 disable DNI , C3543/C3544 use DNI ; U3401 use 47150479;	U3401 use 47150479 , U3501 use 47150585 ; C3543/C3544 disable DNI ; C3531/L3518/Z3502/L3530/C3532/L3517/L3529/L3504/L3505/Z3501/L3528/L3503 use DNI ; 3 、 L3545/L3544 disable DNI;
Appearance	Dimension	the same	the same
	Color	different	different
Accessory	Battery	the same	the same
	External Charger	the same	the same
	USB label	the same	the same
	Earphone	the same	the same

Therefore in this report only RSE need to retest and all the test data in this report are base on previous report with report number **SZEM180100021703**



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4 General Information

4.1 Client Information

Applicant:	Huawei Technologies Co., Ltd.
Address of Applicant:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer:	Huawei Technologies Co., Ltd.
Address of Manufacturer:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Factory:	Huawei Technologies Co., Ltd.
Address of Factory:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

4.2 General Description of EUT

Product Name:	Smart Phone
Model No.:	CLT-L29
Trade Mark:	HUAWEI
Sample Type:	Portable production
Antenna Type:	PIFA Antenna
Antenna Gain:	LTE B26: -2.09dBi

4.3 Test Mode

Test Mode	Test Modes Description
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation

NOTE: The test mode(s) are selected according to relevant radio technology specifications.



4.4 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	52%	
Atmospheric Pressure:	1015Pa	
Temperature	TN	25 °C
Voltage :	VL	3.6V
	VN	3.82V
	VH	4.5V

NOTE: VL= lower extreme test voltage
VN= nominal voltage
VH= upper extreme test voltage
TN= normal temperature



4.5 Test Frequency

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND26 (824-849) 1.4MHz	TX	Channel 26797	Channel 26915	Channel 27033
		824.7 MHz	836.5 MHz	848.3 MHz
	RX	Channel 8697	Channel 8915	Channel 9033
		859.7 MHz	881.5 MHz	893.3 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND26 (824-849) 3MHz	TX	Channel 26805	Channel 26915	Channel 27025
		825.5 MHz	836.5 MHz	847.5 MHz
	RX	Channel 8805	Channel 8915	Channel 9025
		860.5 MHz	881.5 MHz	892.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND26 (824-849) 5MHz	TX	Channel 26815	Channel 26915	Channel 27015
		826.5 MHz	836.5 MHz	846.5 MHz
	RX	Channel 8815	Channel 8915	Channel 9015
		871.5 MHz	881.5 MHz	891.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND26 (824-849) 10MHz	TX	Channel 26840	Channel 26915	Channel 26990
		829 MHz	836.5 MHz	844 MHz
	RX	Channel 8840	Channel 8915	Channel 8990
		874 MHz	881.5 MHz	889 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND26 (824-849) 15MHz	TX	Channel 26865	Channel 26915	Channel 26965
		831.5 MHz	836.5 MHz	841.5 MHz
	RX	Channel 8865	Channel 8915	Channel 8965
		876.5 MHz	881.5 MHz	886.5 MHz



4.6 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China.
518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI**

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

- **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- **Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.8 Deviation from Standards

None.

4.9 Abnormalities from Standard Conditions

None.



4.10 Other Information Requested by the Customer

None.

4.11 Technical Specification

Characteristics	Description	
Radio System Type	☒ LTE	
Supported Frequency Range	LTE band 26(824-849)	Transmission (TX): 824 to 849 MHz
		Receiving (RX): 869 to 894 MHz
Target TX Output Power	LTE band 26(824-849): 23.5dBm	
	LTE band26(824-849)	☒ 1.4 MHz; ☒ 3 MHz; ☒ 5 MHz; ☒ 10 MHz; ☒ 15 MHz

Characteristics	Description	
Designation of Emissions (Note: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	LTE band26 (824-849)	1M11G7D;1M10W7D; 1M10W7D 2M69G7D;2M69W7D; 2M69W7D 4M49G7D;4M48W7D; 4M47W7D 8M97G7D;8M95W7D; 8M99W7D 13M6G7D;13M6W7D; 13M6W7D



5 Description of Tests

5.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Note: Reference test setup 1

5.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 0.8m high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8). Calculate power in dBm by the following formula:

$$\text{ERP (dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$

Where:

Pg is the generator output power into the substitution antenna.



Above 1GHz test procedure as below:

- 1). Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2). Calculate power in dBm by the following formula:
$$\text{EIRP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBi)}$$
$$\text{EIRP} = \text{ERP} + 2.15\text{dB}$$

Where:

Pg is the generator output power into the substitution antenna.
- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete.

Note: Reference test setup 2

5.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1

5.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03



The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Note: Reference test setup 1

5.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1



5.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1

5.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8) Calculate power in dBm by the following formula:

$$\text{ERP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$



Where:

P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to P_g [dBm] – cable loss [dB]. The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$.

Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

$$\text{EIRP(dBm)} = P_g(\text{dBm}) - \text{cable loss (dB)} + \text{antenna gain (dBi)}$$

$$\text{EIRP} = \text{ERP} + 2.15\text{dB}$$

Where:

P_g is the generator output power into the substitution antenna.

3. Test the EUT in the lowest channel, the middle channel the Highest channel
4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
5. Repeat above procedures until all frequencies measured was complete

Note: Reference test setup 3

5.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 Power Meas License Digital Systems v03

. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the



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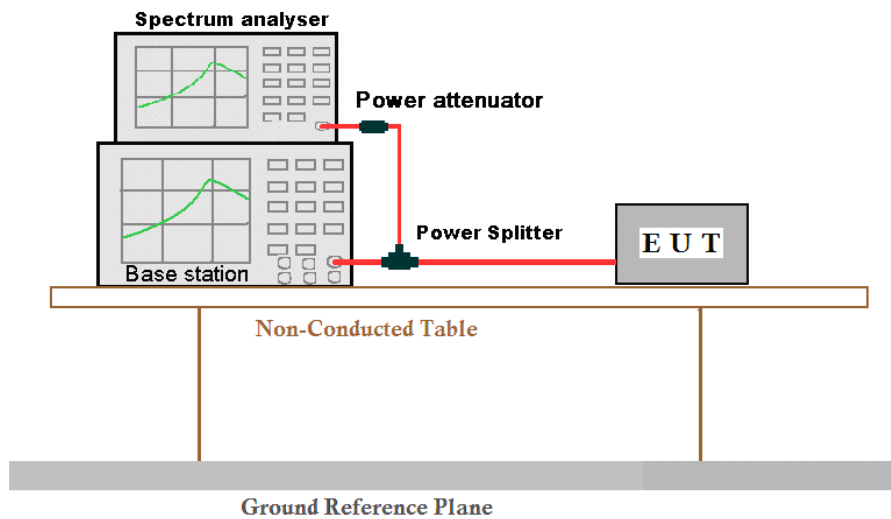
transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.

3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 4

5.9 Test Setups

5.9.1 Test Setup 1



5.9.2 Test Setup 2

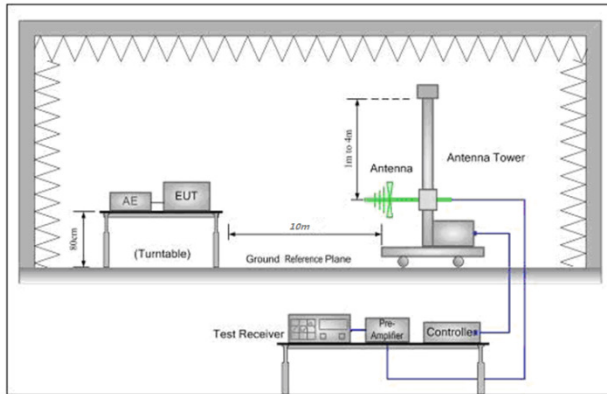


Figure 1. 30MHz to 1GHz

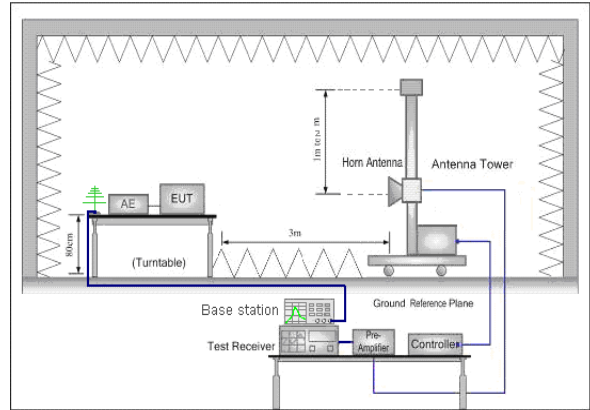


Figure 2. above 1GHz

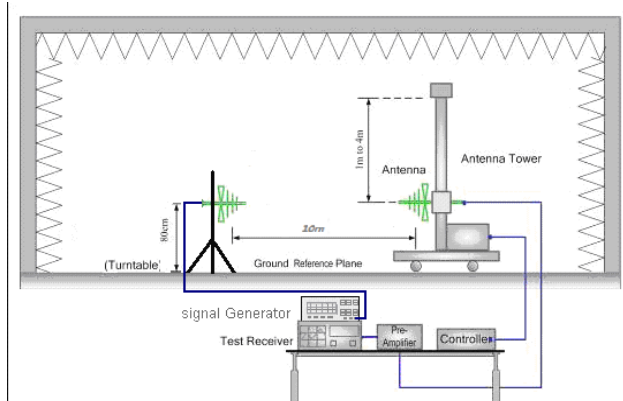


Figure 1. 30MHz to 1GHz

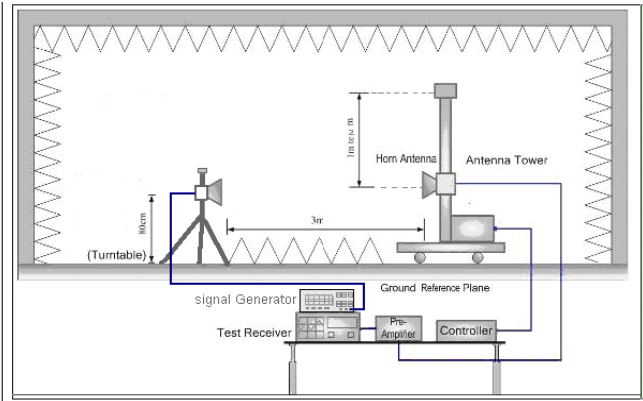


Figure 2. above 1GHz

5.9.3 Test Setup 3

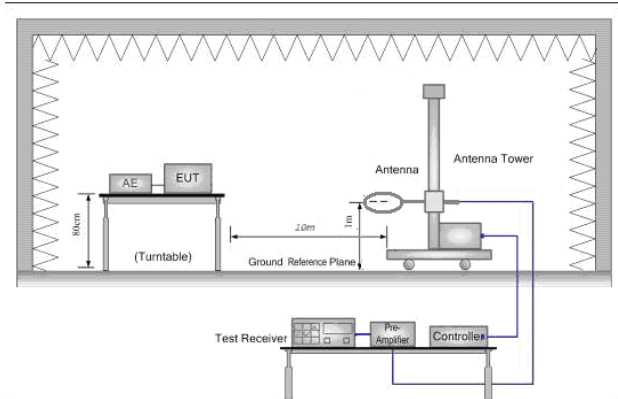


Figure 1. Below 30MHz

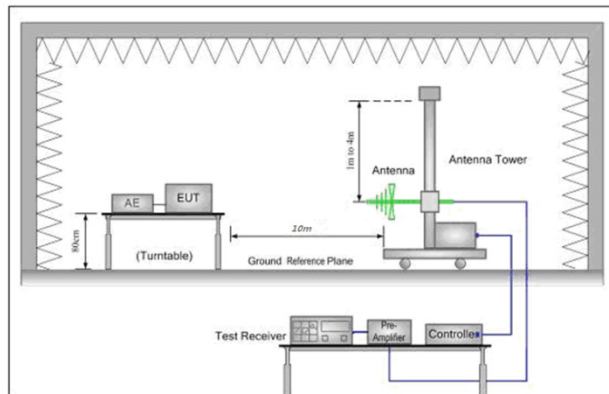


Figure 2. 30MHz to 1GHz

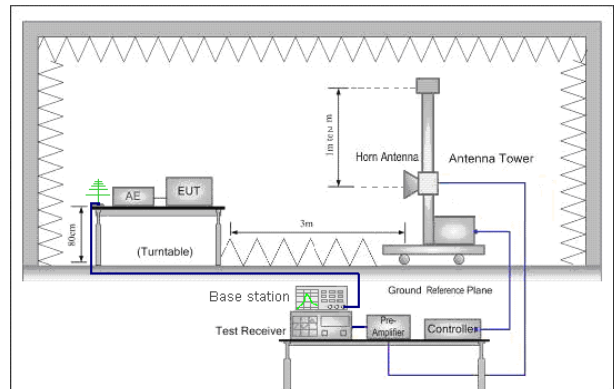


Figure 3. above 1GHz

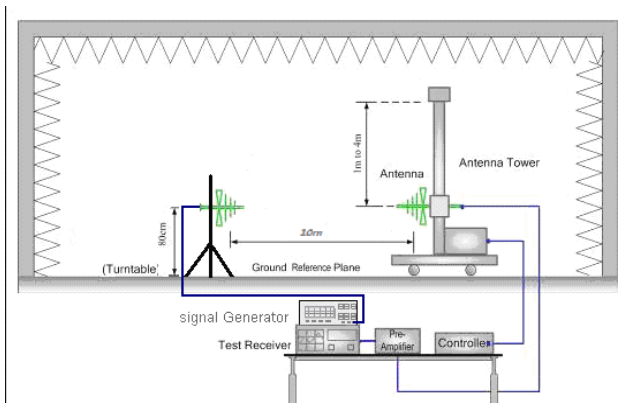


Figure 2. 30MHz to 1GHz

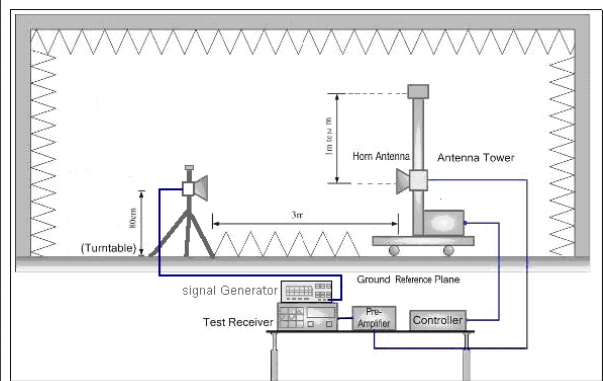
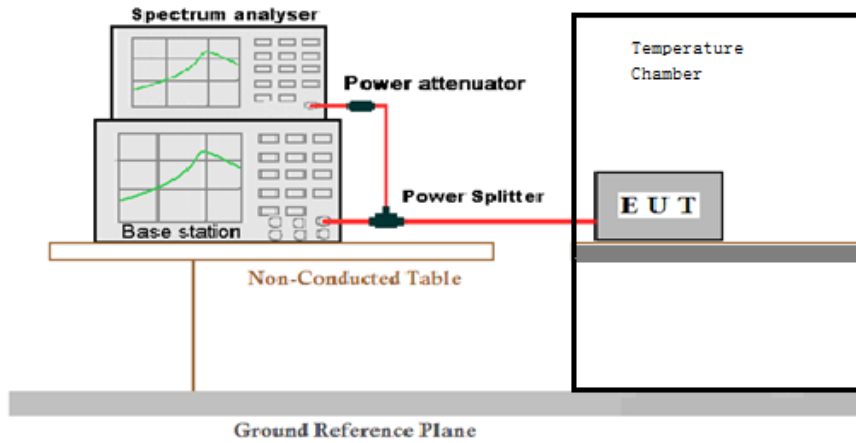


Figure 3. above 1GHz

5.9.4 Test Setup 4





5.10 Test Conditions

Test Case		Test Conditions	
Transmit Output Power Data	Average Power, Total	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
	Average Power, Spectral Density (if required)	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
Peak-to-Average Ratio (if required)		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
Modulation Characteristics		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	M (M= middle channe)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
Bandwidth	Occupied Bandwidth	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
	Emission Bandwidth (if required)	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
Band Edges Compliance		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, H (L= low channel, H= high channel)
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.
Spurious Emission at Antenna		Test Environment	Ambient Climate & Rated Voltage



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Terminals	Test Setup	Test Setup 1
	RF Channels (TX)	L,M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	LTE/TM1.
Field Strength of Spurious Radiation	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 2
	Test Mode	LTE/TM1; NOTE: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
	Test Setup	Test Setup 4
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	LTE/TM1;LTE/TM2;LTE/TM3.



6 Main Test Instruments

RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2017-05-10	2018-05-10
2	EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2017-10-09	2018-10-09
3	BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-02	2017-11-15	2020-11-15
4	Double-ridged horn (1-18GHz)	ETS-LINDGREN	3117	SEM003-11	2015-10-17	2018-10-17
5	Horn Antenna (18-26GHz)	ETS-LINDGREN	3160	SEM003-12	2017-11-24	2020-11-24
6	Pre-amplifier (0.1-1300MHz)	Agilent Technologies	8447D	SEM005-01	2017-04-14	2018-04-14
7	Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-10	2017-10-17	2018-10-17
8	Band filter	Amindeon	82346	SEM023-01	N/A	N/A
9	Universal radio communication tester	Rohde & Schwarz	CMU200	SEM010-01	2017-10-09	2018-10-09
10	Universal radio communication tester	Rohde & Schwarz	CMW500	SEM010-03	2017-10-23	2018-10-23
11	DC Power Supply	Zhao Xin	RXN-305D	SEM011-02	2017-10-09	2018-10-09
12	BiConiLog Antenna (30MHz-3GHz)	Schwarzbeck	VULB9163	SEM003-05	2015-10-17	2018-10-17
13	Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-06	2015-06-14	2018-06-14



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RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)
1	10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2017-05-10	2018-05-10
2	EMI Test Receiver (9k-7GHz)	Rohde & Schwarz	ESR	SEM004-03	2017-04-14	2018-04-14
3	Trilog-Broadband Antenna(30M-1GHz)	Schwarzbeck	VULB9168	SEM003-18	2016-06-29	2019-06-29
4	Pre-amplifier	Sonoma Instrument Co	310N	SEM005-03	2017-07-06	2018-07-06
5	.Loop Antenna	ETS-Lindgren	6502	SEM003-08	2015-08-14	2018-08-14

RF connected test						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	Humi/ Temp Indicator	MingGao	TH101B	W006-09	2017-03-09	2018-03-09
2	Signal Analyzer	Rohde Schwarz	FSV	W005-02	2017-03-06	2018-03-06
3	Barometer	ChangChun	DYM3	SEL0088	2017-05-24	2018-05-24
4	Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66319D	W009-02	2017-07-23	2018-07-23
5	Digital Multimeter	Fluke	15B+	W055-01	2017-03-09	2018-03-09
6	Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	W005-02	2017-03-06	2018-03-06
7	Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2017-03-06	2018-03-06



7 Measurement Uncertainty

For a 95% confidence level ($k = 2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data
Transmit Output Power Data	Power [dBm]	U = 0.37 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 2.0 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber: U = 4.5 dB (30 MHz to 1GHz) U = 3.3 dB (above 1 GHz) For 10 m Chamber: U = 4.5 dB (30 MHz to 1GHz) U = 3.2 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.24 ppm

8 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1801000218RG

The End